## MO14555B;#M & 14556B

# **Dual Binary to 1-of-4 Decoder/Demultiplexer**

The MC14555B and MC14556B are constructed with complementary MOS (CMOS) enhancement mode devices. Each Decoder/Demultiplexer has two select inputs (A and B), an active low Enable input (E), and four mutually exclusive outputs (Q0, Q1, Q2, Q3). The MC14555B has the selected output go to the "high" state, and the MC14556B has the selected output go to the "low" state. Expanded decoding such as binary-to-hexadecimal (1-of-16), etc., can be achieved by using other MC14555B or MC14556B devices.

Applications include code conversion, address decoding, memory selection control, and demultiplexing (using the Enable input as a data input) in digital data transmission systems.

#### **Features**

- Diode Protection on All Inputs
- Active High or Active Low Outputs
- Expandable
- Supply Voltage Range = 3.0 Vdc to 18 Vdc
- All Outputs Buffered
- Capable of Driving Two Low-Power TTL Loads or One Low-Power Schottky TTL Load Over the Rated Temperature Range
- Pb-Free Packages are Available\*

## MAXIMUM RATINGS (Voltages Referenced to VSS)

Parameter	Symbol	Value	Unit
DC Supply Voltage Range	$V_{DD}$	-0.5 to +18.0	V
Input or Output Voltage Range (DC or Transient)	V <sub>in</sub> , V <sub>out</sub>	-0.5 to V <sub>DD</sub> + 0.5	V
Input or Output Current (DC or Transient) per Pin	I <sub>in</sub> , I <sub>out</sub>	±10	mA
Power Dissipation, per Package (Note 1)	P <sub>D</sub>	500	mW
Ambient Temperature Range	T <sub>A</sub>	-55 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C
Lead Temperature (8–Second Soldering)	TL	260	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

 Temperature Derating: Plastic "P and D/DW" Packages: – 7.0 mW/°C From 65°C To 125°C

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high–impedance circuit. For proper operation,  $V_{in}$  and  $V_{out}$  should be constrained to the range  $V_{SS} \leq (V_{in} \text{ or } V_{out}) \leq V_{DD}.$ 

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either  $V_{SS}$  or  $V_{DD}$ ). Unused outputs must be left open.

\*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.



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MARKING DIAGRAMS



PDIP-16 P SUFFIX CASE 648 

SOIC-16 D SUFFIX CASE 751B 16 \_\_\_\_\_\_ 1455xBG \_o AWLYWW



SOEIAJ-16 F SUFFIX CASE 966 x = 5 or 6

A = Assembly Location

 $\begin{array}{ll} WL,\,L &= Wafer\ Lot \\ YY,\,Y &= Year \\ WW,\,W &= Work\ Week \\ G &= Pb-Free\ Package \\ \end{array}$ 

## **PIN ASSIGNMENTS**

	MC1455	5B		MC14556B				
Ē <sub>A</sub> [	1 ●	16	V <sub>DD</sub>	Ē <sub>A</sub> [	1 ●	16	V <sub>DD</sub>	
A <sub>A</sub>	2	15	ΕB	A <sub>A</sub> [	2	15	ΕB	
ВА	3	14	A <sub>B</sub>	ВА	3	14	A <sub>B</sub>	
Q0 <sub>A</sub>	4	13	B <sub>B</sub>	Q0 <sub>A</sub> □	4	13	ВВ	
Q1 <sub>A</sub>	5	12	Q0 <sub>B</sub>	Q1 <sub>A</sub>	5	12	□ <del>Q</del> 0 <sub>B</sub>	
Q2 <sub>A</sub>	6	11	Q1 <sub>B</sub>	Q2 <sub>A</sub> □	6	11	Q1 <sub>B</sub>	
Q3 <sub>A</sub>	7	10	Q2 <sub>B</sub>	Q3 <sub>A</sub> □	7	10		
V <sub>SS</sub> [	8	9	Q3 <sub>B</sub>	v <sub>ss</sub> [	8	9	□ <del>Q</del> 3 <sub>B</sub>	

#### ORDERING INFORMATION

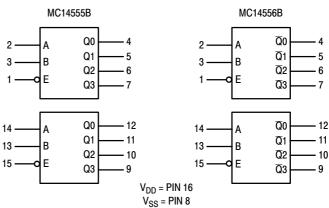
See detailed ordering and shipping information in the package dimensions section on page 4 of this data sheet.

## 查询"MC14555BCPG"供应商

1	1VI	<del></del>				7 17	***	- 1-1			
	lı	nput	S		Outputs						
	Enable	Enable Select			MC1	<b>4555</b>	В	N	/IC14	556	В
	Ē	В	Α	Q3	Q2	Q1	Q0	Q3	Q2	Q1	Q0
	0	0	0	0	0	0	1	1	1	1	0
	0	0	1	0	0	1	0	1	1	0	1
	0	1	0	0	1	0	0	1	0	1	1
	0	1	1	1	0	0	0	0	1	1	1
	1	Х	Х	0	0	0	0	1	1	1	1

X = Don't Care

## **BLOCK DIAGRAM**



## **ELECTRICAL CHARACTERISTICS** (Voltages Referenced to V<sub>SS</sub>)

			- 5	5°C	25°C		12	5°C		
Characteristic	Symbol	V <sub>DD</sub> Vdc	Min	Max	Min	Typ (Note 2)	Max	Min	Max	Unit
Output Voltage "0" Level V <sub>in</sub> = V <sub>DD</sub> or 0	V <sub>OL</sub>	5.0 10 15	- - -	0.05 0.05 0.05	- - -	0 0 0	0.05 0.05 0.05	- - -	0.05 0.05 0.05	Vdc
V <sub>in</sub> = 0 or V <sub>DD</sub> "1" Level	V <sub>OH</sub>	5.0 10 15	4.95 9.95 14.95	- - -	4.95 9.95 14.95	5.0 10 15	- - -	4.95 9.95 14.95	- - -	Vdc
Input Voltage "0" Level $(V_O = 4.5 \text{ or } 0.5 \text{ Vdc})$ $(V_O = 9.0 \text{ or } 1.0 \text{ Vdc})$ $(V_O = 13.5 \text{ or } 1.5 \text{ Vdc})$	V <sub>IL</sub>	5.0 10 15	- - -	1.5 3.0 4.0	- - -	2.25 4.50 6.75	1.5 3.0 4.0	- - -	1.5 3.0 4.0	Vdc
"1" Level ( $V_O = 0.5 \text{ or } 4.5 \text{ Vdc}$ ) ( $V_O = 1.0 \text{ or } 9.0 \text{ Vdc}$ ) ( $V_O = 1.5 \text{ or } 13.5 \text{ Vdc}$ )	V <sub>IH</sub>	5.0 10 15	3.5 7.0 11	1 1 1	3.5 7.0 11	2.75 5.50 8.25	1 1 1	3.5 7.0 11	1 1 1	Vdc
	ІОН	5.0 5.0 10 15	- 3.0 - 0.64 - 1.6 - 4.2		- 2.4 - 0.51 - 1.3 - 3.4	- 4.2 - 0.88 - 2.25 - 8.8		- 1.7 - 0.36 - 0.9 - 2.4		mAdc
	I <sub>OL</sub>	5.0 10 15	0.64 1.6 4.2	- - -	0.51 1.3 3.4	0.88 2.25 8.8	- - -	0.36 0.9 2.4	- - -	mAdc
Input Current	l <sub>in</sub>	15	-	±0.1	-	±0.00001	±0.1	-	±1.0	μAdc
Input Capacitance, (V <sub>in</sub> = 0)	C <sub>in</sub>	-	_	-	-	5.0	7.5	_	-	pF
Quiescent Current (Per Package)	I <sub>DD</sub>	5.0 10 15	- - -	5.0 10 20	_ _ _	0.005 0.010 0.015	5.0 10 20	- - -	150 300 600	μAdc
Total Supply Current (Notes 3, 4) (Dynamic plus Quiescent, Per Package) (C <sub>L</sub> = 50 pF on all outputs, all buffers switching)	I <sub>T</sub>	5.0 10 15			$I_{T} = (1$	.85 μΑ/kHz) .70 μΑ/kHz) .60 μΑ/kHz)	f + I <sub>DD</sub>			μAdc

<sup>2.</sup> Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

The formulas given are for the typical characteristics only at 25°C.
 To calculate total supply current at loads other than 50 pF: I<sub>T</sub>(C<sub>L</sub>) = I<sub>T</sub>(50 pF) + (C<sub>L</sub> – 50) Vfk where: I<sub>T</sub> is in μA (per package), C<sub>L</sub> in pF, V = (V<sub>DD</sub> – V<sub>SS</sub>) in volts, f in kHz is input frequency, and k = 0.002.

**SWITCHING CHARACTERISTICS** (Note 5) ( $C_L = 50 \text{ pF}$ ,  $T_A = 25^{\circ}\text{C}$ )

E In Wic 14333BCFG  共元[8]  Characteristic	Symbol	V <sub>DD</sub>	Min	Typ (Note 6)	Max	Unit
Output Rise and Fall Time $t_{TLH}, t_{THL} = (1.5 \text{ ns/pF}) C_L + 25 \text{ ns}$ $t_{TLH}, t_{THL} = (0.75 \text{ ns/pF}) C_L + 12.5 \text{ ns}$ $t_{TLH}, t_{THL} = (0.55 \text{ ns/pF}) C_L + 9.5 \text{ ns}$	t <sub>TLH</sub> , t <sub>THL</sub>	5.0 10 15	- - -	100 50 40	200 100 80	ns
Propagation Delay Time – A, B to Output $t_{PLH}$ , $t_{PHL}$ = (1.7 ns/pF) $C_L$ + 135 ns $t_{PLH}$ , $t_{PHL}$ = (0.66 ns/pF) $C_L$ + 62 ns $t_{PLH}$ , $t_{PHL}$ = (0.5 ns/pF) $C_L$ + 45 ns	t <sub>PLH</sub> , t <sub>PHL</sub>	5.0 10 15	- - -	220 95 70	440 190 140	ns
Propagation Delay Time – E to Output $t_{PLH}$ , $t_{PHL}$ = (1.7 ns/pF) $C_L$ + 115 ns $t_{PLH}$ , $t_{PHL}$ = (0.66 ns/pF) $C_L$ + 52 ns $t_{PLH}$ , $t_{PHL}$ = (0.5 ns/pF) $C_L$ + 40 ns	t <sub>PLH</sub> , t <sub>PHL</sub>	5.0 10 15	- - -	200 85 65	400 170 130	ns

- 5. The formulas given are for the typical characteristics only at 25°C.
- 6. Data labelled "Typ" is not to be used for design purposes but is intended as an indication of the IC's potential performance.

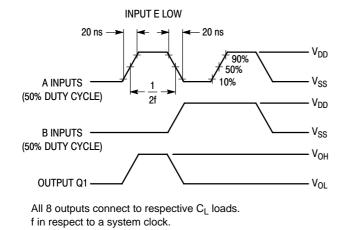


Figure 1. Dynamic Power Dissipation Signal Waveforms

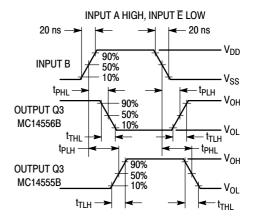
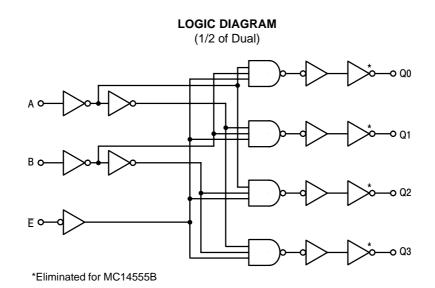


Figure 2. Dynamic Signal Waveforms



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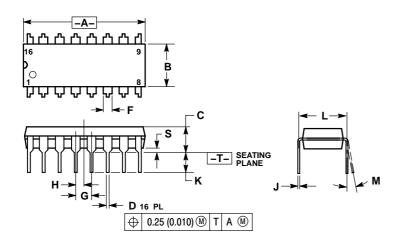
Device	Package	Shipping <sup>†</sup>
MC14555BCP	PDIP-16	
MC14555BCPG	PDIP-16 (Pb-Free)	25 Units / Rail
MC14555BD	SOIC-16	
MC14555BDG	SOIC-16 (Pb-Free)	48 Units / Rail
MC14555BDR2	SOIC-16	
MC14555BDR2G	SOIC-16 (Pb-Free)	2500 / Tape & Reel
MC14555BFEL	SOEIAJ-16	
MC14555BFELG	SOEIAJ-16 (Pb-Free)	2000 / Tape & Reel
MC14556BCP	PDIP-16	
MC14556BCPG	PDIP-16 (Pb-Free)	25 Units / Rail
MC14556BD	SOIC-16	48 Units / Rail
MC14556BDR2	SOIC-16	
MC14556BDR2G	SOIC-16 (Pb-Free)	2500 / Tape & Reel
MC14556BF	SOEIAJ-16	50 Units / Tube
MC14556BFEL	SOEIAJ-16	
MC14556BFELG	SOEIAJ-16 (Pb-Free)	2000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

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### PACKAGE DIMENSIONS

## PDIP-16 CASE 648-08 **ISSUE T**



#### NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: INCH.

  3. DIMENSION L TO CENTER OF LEADS WHEN FORMED PARALLEL.

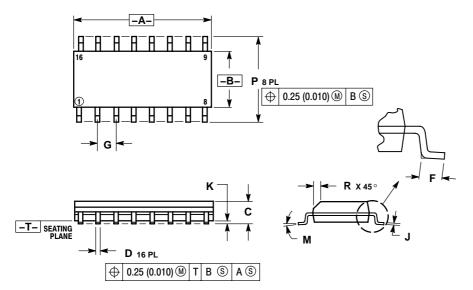
  4. DIMENSION B DOES NOT INCLUDE

- MOLD FLASH.

  5. ROUNDED CORNERS OPTIONAL.

	INC	HES	MILLIN	IETERS	
DIM	MIN	MAX	MIN	MAX	
Α	0.740	0.770	18.80	19.55	
В	0.250	0.270	6.35	6.85	
С	0.145	0.175	3.69	4.44	
D	0.015	0.021	0.39	0.53	
F	0.040	0.70	1.02	1.77	
G	0.100	BSC	2.54 BSC		
Н	0.050	BSC	1.27 BSC		
J	0.008	0.015	0.21	0.38	
K	0.110	0.130	2.80	3.30	
L	0.295	0.305	7.50	7.74	
M	0°	10 °	0°	10 °	
S	0.020	0.040	0.51	1.01	

## SOIC-16 CASE 751B-05 **ISSUE J**



## NOTES:

- NOTES:

  1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

  2. CONTROLLING DIMENSION: MILLIMETER.

  3. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION.

  4. MAXIMUM MOLD PROTRUSION 0.15 (0.006)

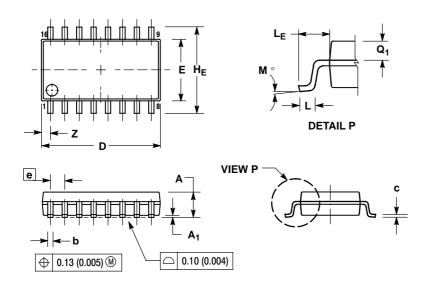
- PER SIDE.
  DIMENSION D DOES NOT INCLUDE DAMBAR DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.

	MILLIN	IETERS	INC	HES
DIM	MIN	MAX	MIN	MAX
Α	9.80	10.00	0.386	0.393
В	3.80	4.00	0.150	0.157
С	1.35	1.75	0.054	0.068
D	0.35	0.49	0.014	0.019
F	0.40	1.25	0.016	0.049
G	1.27	BSC	0.050	BSC
J	0.19	0.25	0.008	0.009
K	0.10	0.25	0.004	0.009
M	0°	7°	0°	7°
P	5.80	6.20	0.229	0.244
R	0.25	0.50	0.010	0.019

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#### PACKAGE DIMENSIONS

SOEIAJ-16 CASE 966-01 ISSUE A



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
  Y14 5M 1982
- 2. CONTROLLING DIMENSION: MILLIMETER.
- DIMENSIONS D AND E DO NOT INCLUDE
  MOLD FLASH OR PROTRUSIONS AND ARE
  MEASURED AT THE PARTING LINE. MOLD FLASH
  OR PROTRUSIONS SHALL NOT EXCEED 0.15
  (0.006) PER SIDE.

   TERMINAL NUMBERS ARE SHOWN FOR
- TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
   THE LEAD WIDTH DIMENSION (b) DOES NOT
- 5. THE LEAD WIDTH DIMENSION (b) DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.08 (0.003) TOTAL IN EXCESS OF THE LEAD WIDTH DIMENSION AT MAXIMUM MATERIAL CONDITION. DAMBAR CANNOT BE LOCATED ON THE LOWER RADIUS OR THE FOOT. MINIMUM SPACE BETWEEN PROTRUSIONS AND ADJACENT LEAD TO BE 0.46 (0.018).

	MILLIN	IETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α		2.05		0.081	
A <sub>1</sub>	0.05	0.20	0.002	0.008	
b	0.35	0.50	0.014	0.020	
C	0.10	0.20	0.007	0.011	
D	9.90	10.50	0.390	0.413	
Е	5.10	5.45	0.201	0.215	
е	1.27	BSC	0.050 BSC		
HE	7.40	8.20	0.291	0.323	
L	0.50	0.85	0.020	0.033	
LΕ	1.10	1.50	0.043	0.059	
M	0 °	10 °	0 °	10°	
Q	0.70	0.90	0.028	0.035	
Z		0.78		0.031	

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